

Figure 1 Supplementary Data1

Powder-XRD data were collected in reflection mode at room temperature and under ambient conditions with a Simens D-500 powder diffractometer, using Cu K α radiation ($\lambda=1.5418\text{\AA}$) and an applied voltage and current of 40 kV and 25 mA, respectively. Acquisition range from 3° to 70°, step size of 0.02° and acquisition time of 5 sec/step.

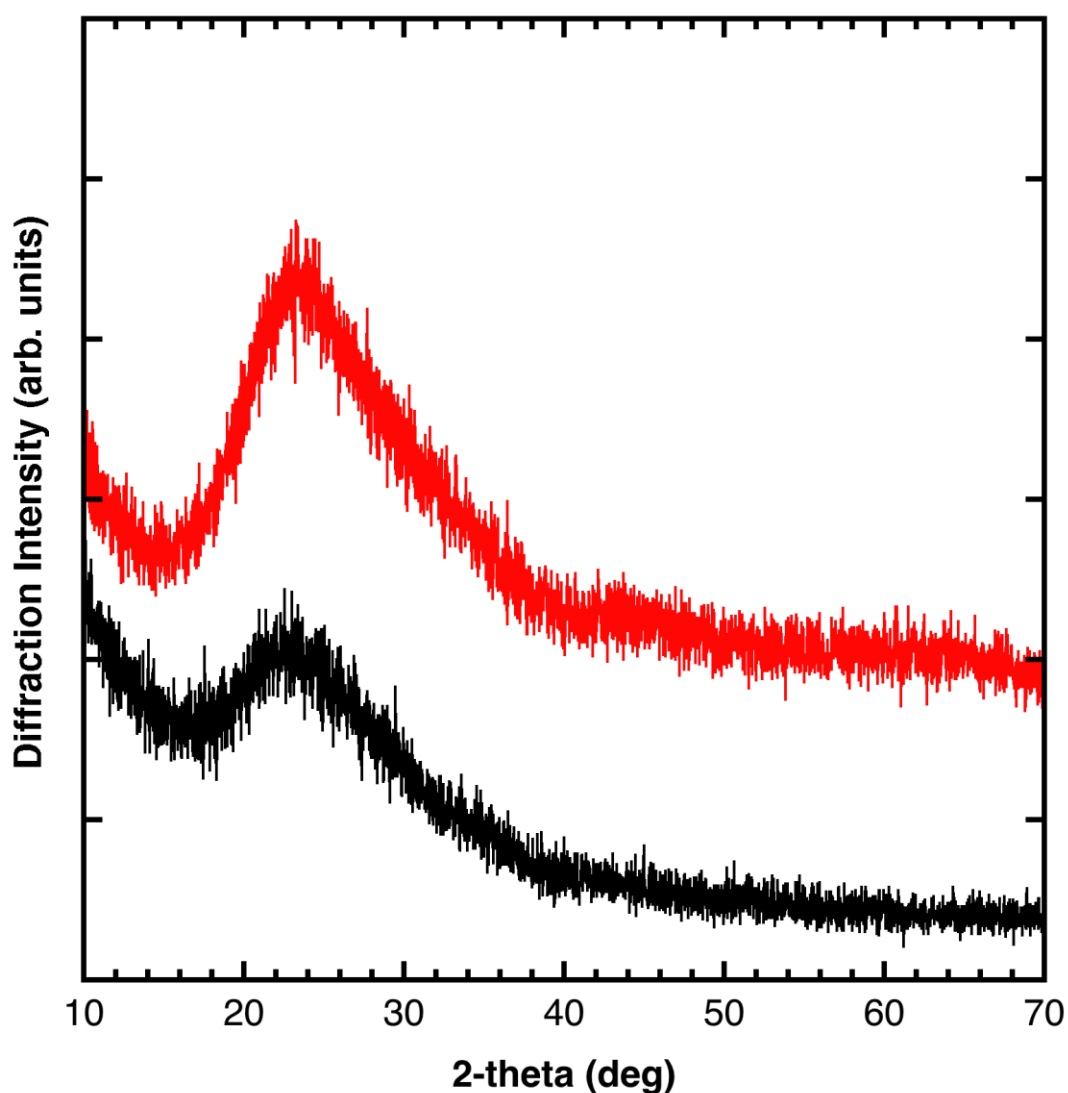


Figure 1: XRD patterns of two hydrous experimental glasses. No crystalline phases were identified.